

The background of the slide is a photograph of the International Space Station (ISS) in orbit above Earth. The station's complex structure, including its large solar panel arrays and various modules, is clearly visible against the blackness of space. Below the station, the Earth's surface is shown, featuring a blue ocean and white clouds. The horizon of the planet curves across the lower portion of the image.

# Operation and Performance of the AMS-02 Silicon Tracker

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On behalf of the AMS Tracker Collaboration

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VERTEX 2014 Workshop



## Outline

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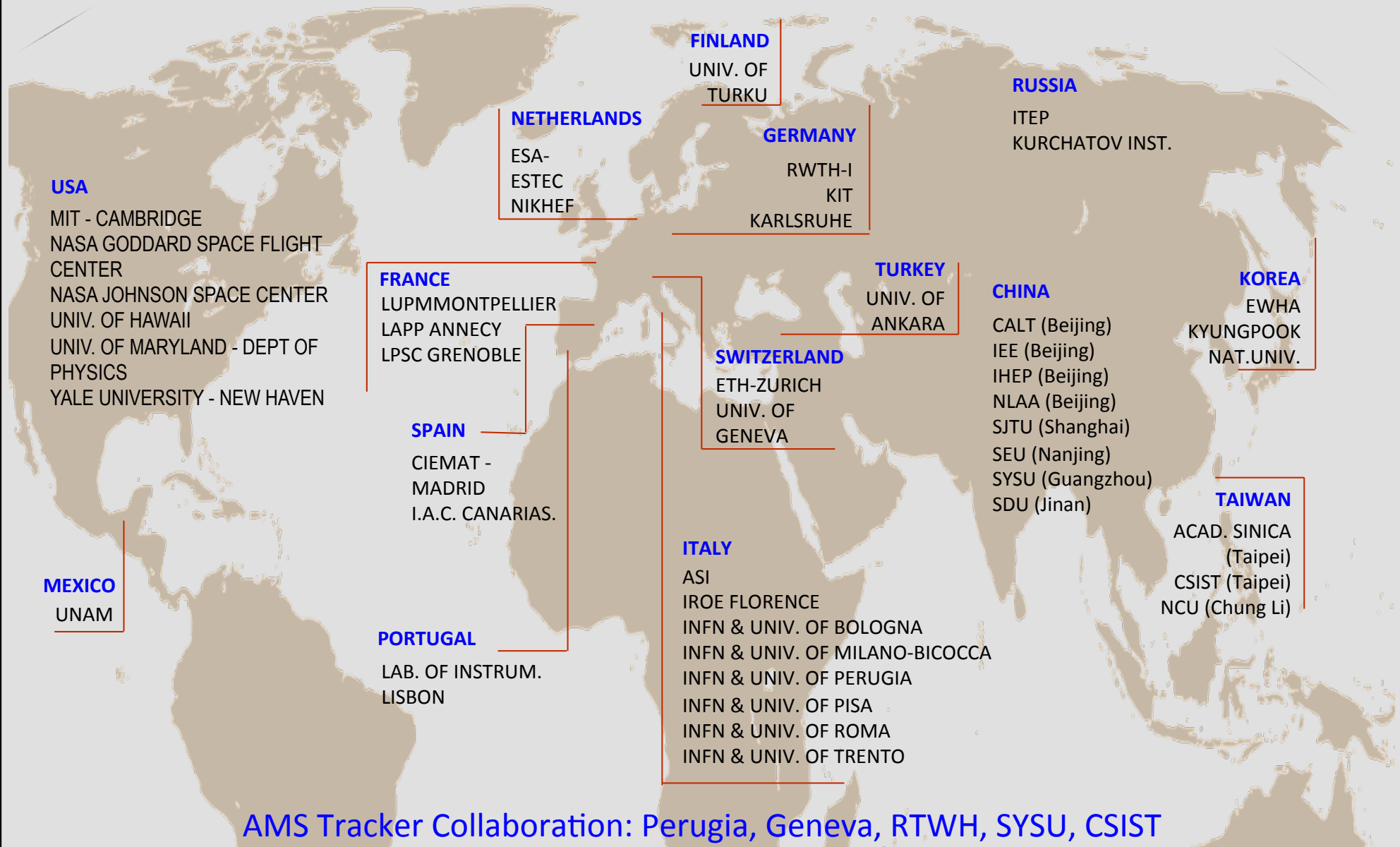


1. AMS-02 and its Silicon Tracker
2. Space Operation of the Silicon Tracker
3. Performances of the Silicon Tracker
4. Particle Charge Identification

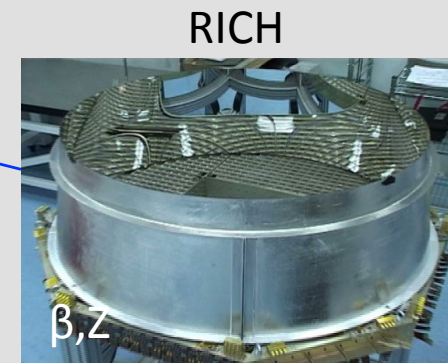
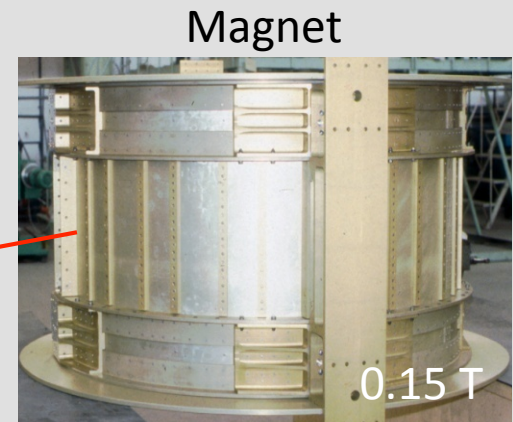
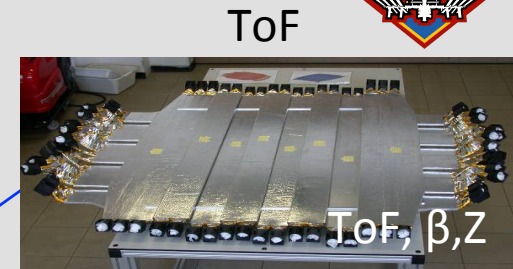
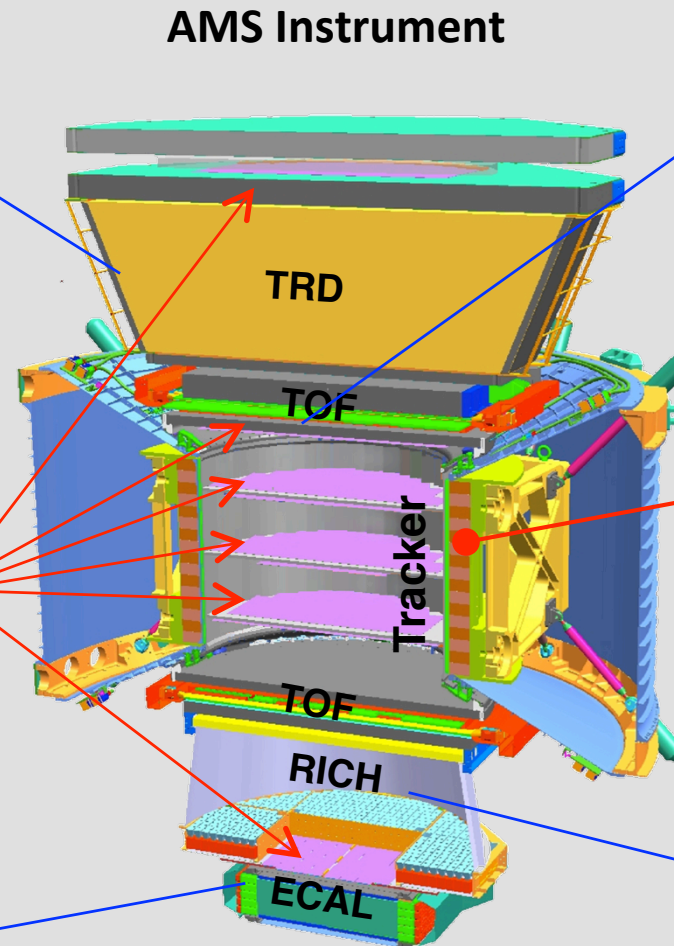
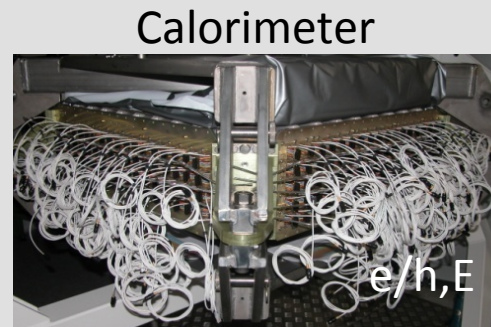
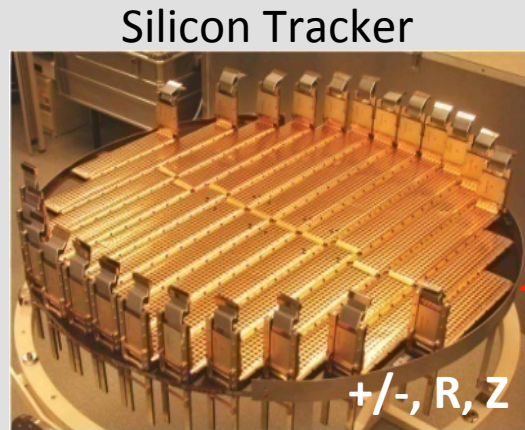
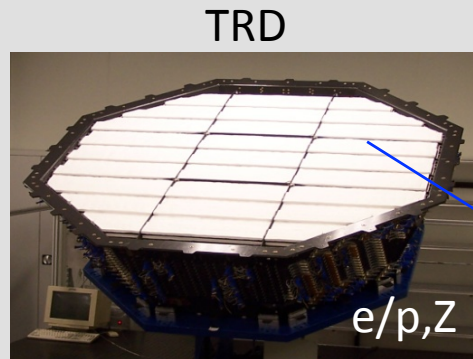
# The AMS-02 Collaboration



15 Countries, 44 institutions and more then 600 Physicists.



# The Instrument



Goal : Cosmic Ray Properties from few GeV to few TeV

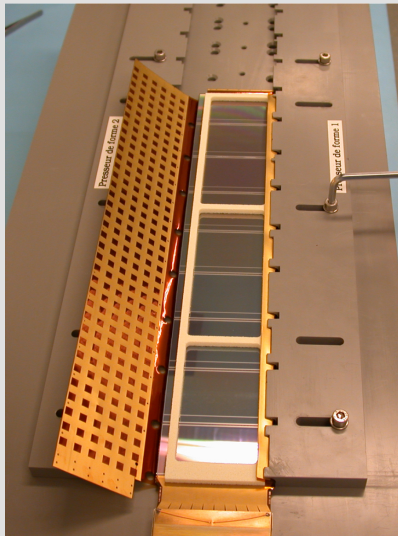


# The Silicon Tracker

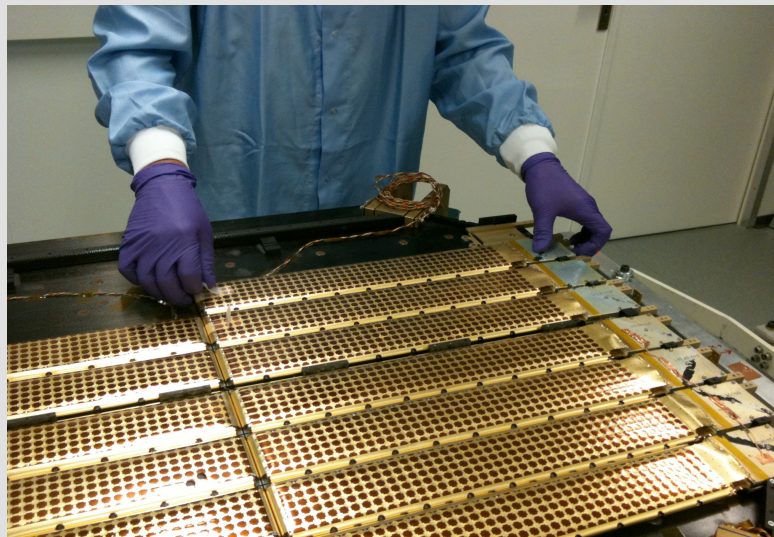


- 2284, 300 $\mu$ m thick, double-sided silicon micro-strip sensors (p+-n-n+)
- 7 to 15 sensors arranged in basic functional units (ladders)
- Intrinsic position resolution : 10 (30)  $\mu$ m in  $y(x)$  bending (non-bending)
- 6 honeycomb carbon fiber planes (0.04  $X_0$ )
- 196k channels  $\rightarrow$  192 Watts
- 126 Watts cooled by Tracker Thermal Control System (2 phase CO<sub>2</sub>)
- Operational temperature range : -10°C to 25 °C.

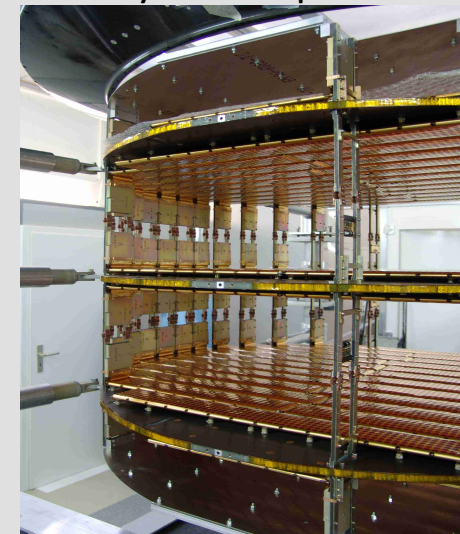
2284 sensors



192 ladders



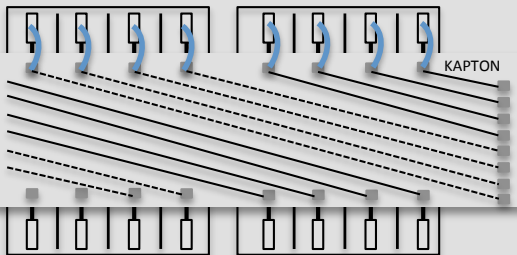
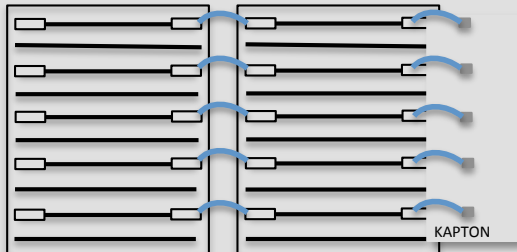
9 layers in 6 planes



# The Silicon Ladder Readout Chain



Y-side – p+ strips



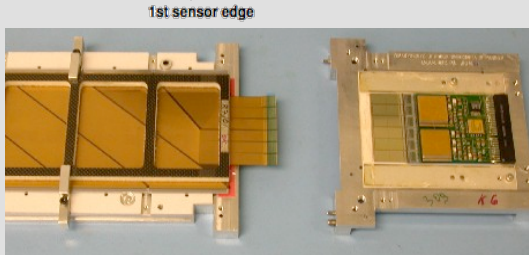
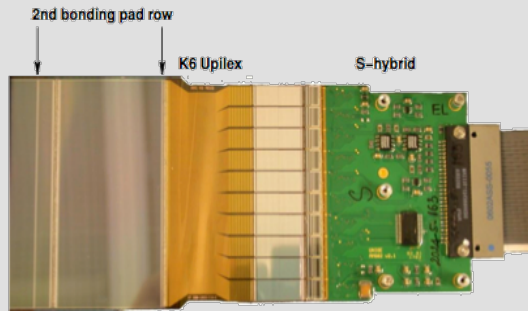
X-side – n+ strips

## Sensors

- 300 $\mu$ m, 72x41mm<sup>2</sup>
- Strip pitch : 27.5 (104) for Y(X)
- reverse biased at 50 V
- Readout pitch : 110 (208)
- Capacitive coupling : 1 pF/cm
- Charge sharing

To  
Y-side  
Electronics

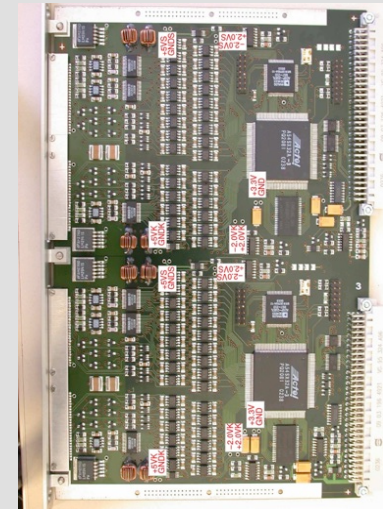
To  
X-side  
Electronics



## Front-Ends

- 10 (6) VAs Y (X)
- Amplification (100 MIP)
- Shaping ( $\sim 4 \mu$ s)
- Sample-and-Hold
- 0.7 mW / channel

To  
Digitizat.



## Data Reduction

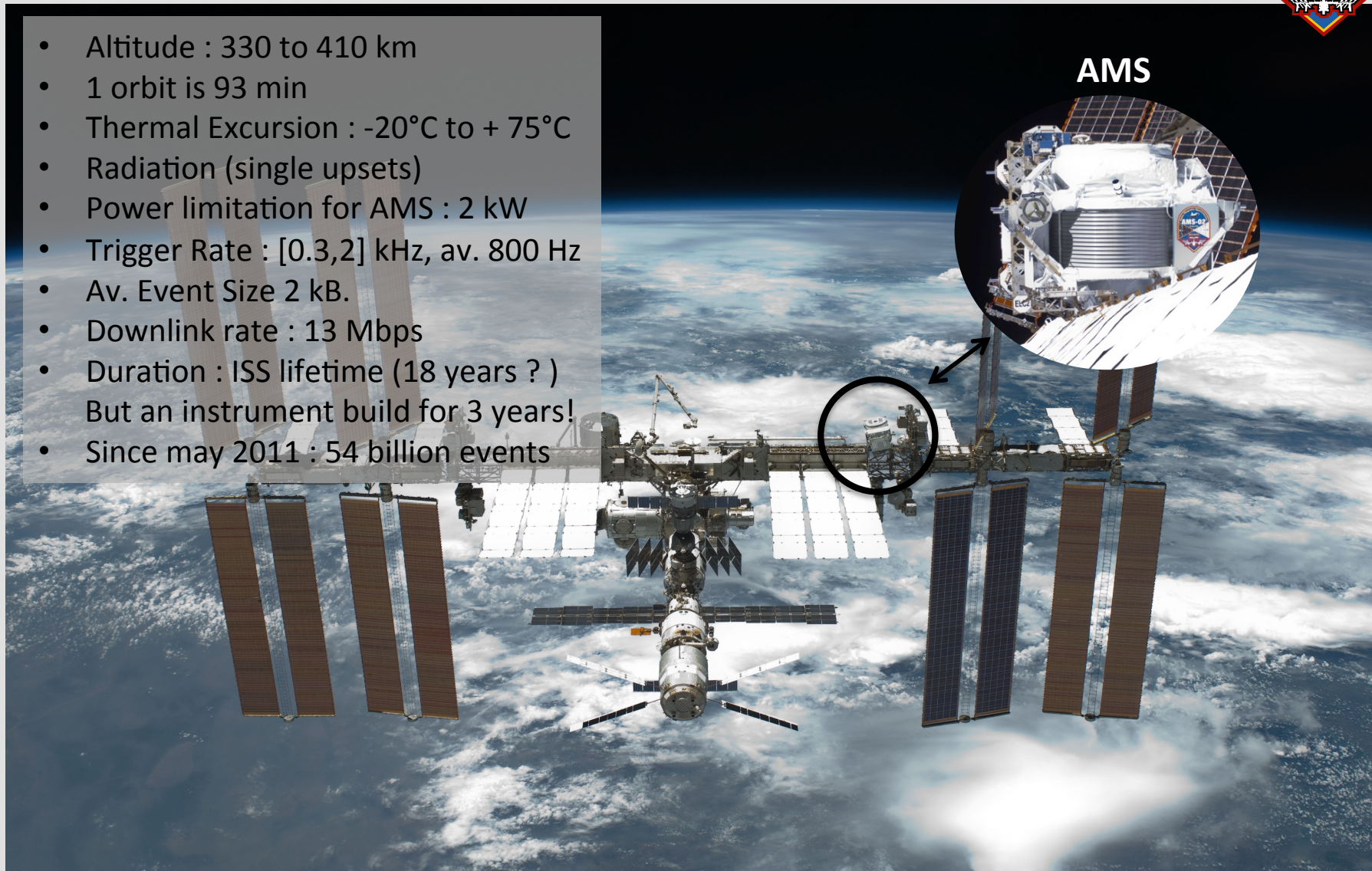
- Three 12 bits ADC
- Pedestal/Noise Eval.
- Common Noise Subtraction
- Cluster Search
- Compression (1000)



## AMS on the ISS (since 19 May 2011)



- Altitude : 330 to 410 km
- 1 orbit is 93 min
- Thermal Excursion :  $-20^{\circ}\text{C}$  to  $+75^{\circ}\text{C}$
- Radiation (single upsets)
- Power limitation for AMS : 2 kW
- Trigger Rate :  $[0.3, 2]$  kHz, av. 800 Hz
- Av. Event Size 2 kB.
- Downlink rate : 13 Mbps
- Duration : ISS lifetime (18 years ? )  
But an instrument build for 3 years!
- Since May 2011 : 54 billion events

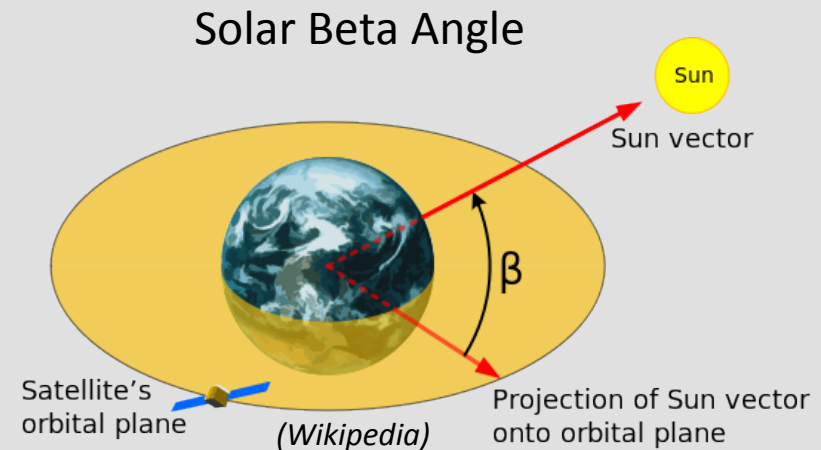


# Thermal challenges for on-orbit operations



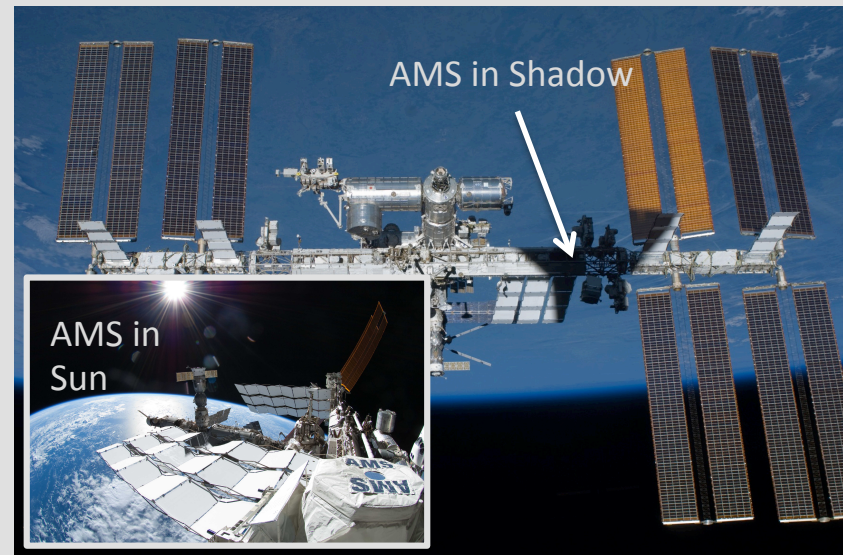
## Thermal environment variables:

- Orbital properties, day/night
- Solar beta angle
- Radiator and solar panel positions
- Space craft attitude, visiting vehicles, re-boost
- Time scales: Months, days, hours, minutes



## Results of thermal environment:

- Thermo-mechanical deformations
- Noise level and gain shift in electronic components
- Damaging effects outside survival or operational temperature range



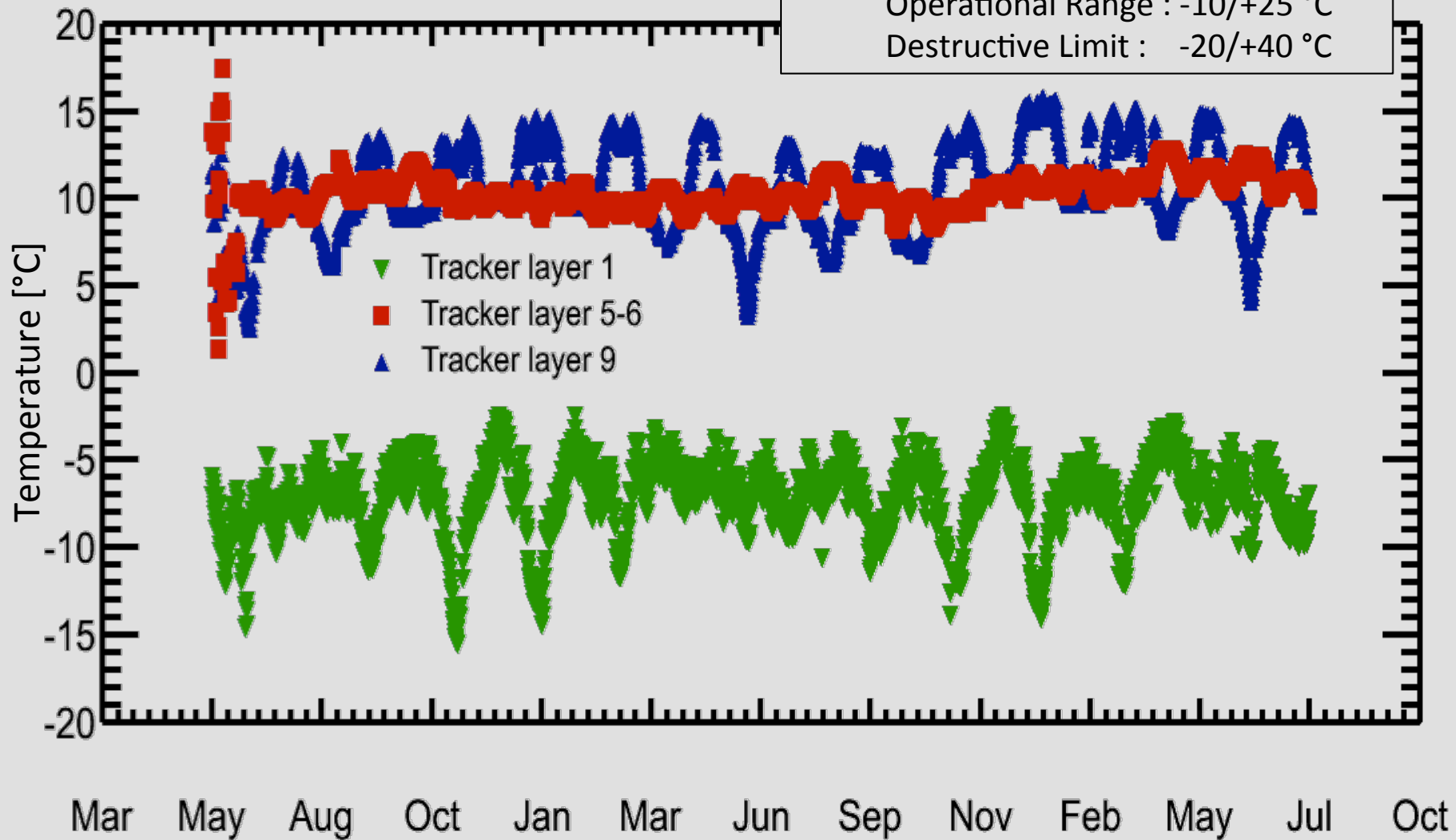


# Tracker Temperatures

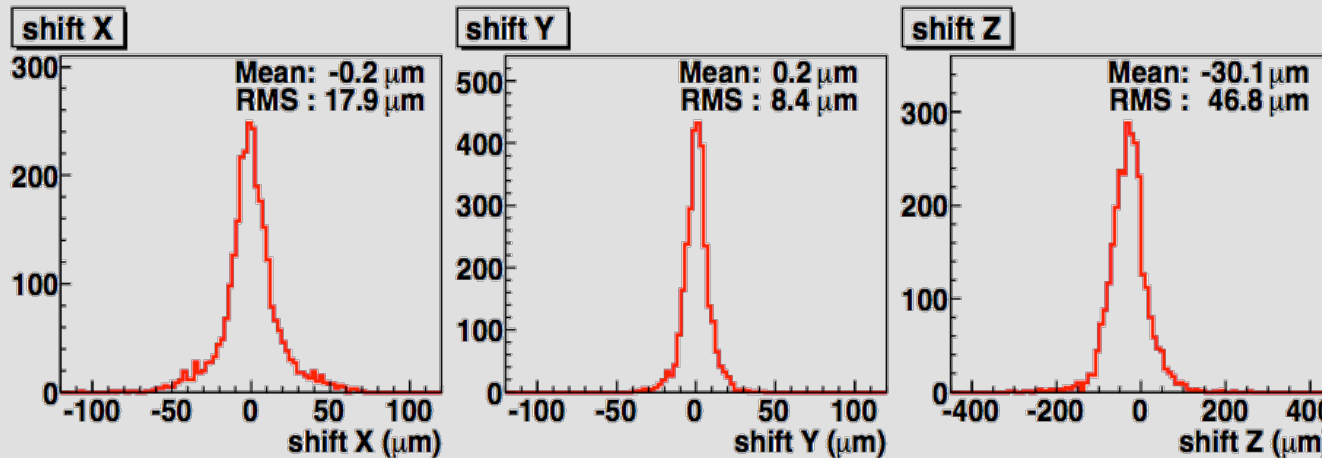


Only passive thermal control for external layers.

Operational Range : -10/+25 °C  
Destructive Limit : -20/+40 °C

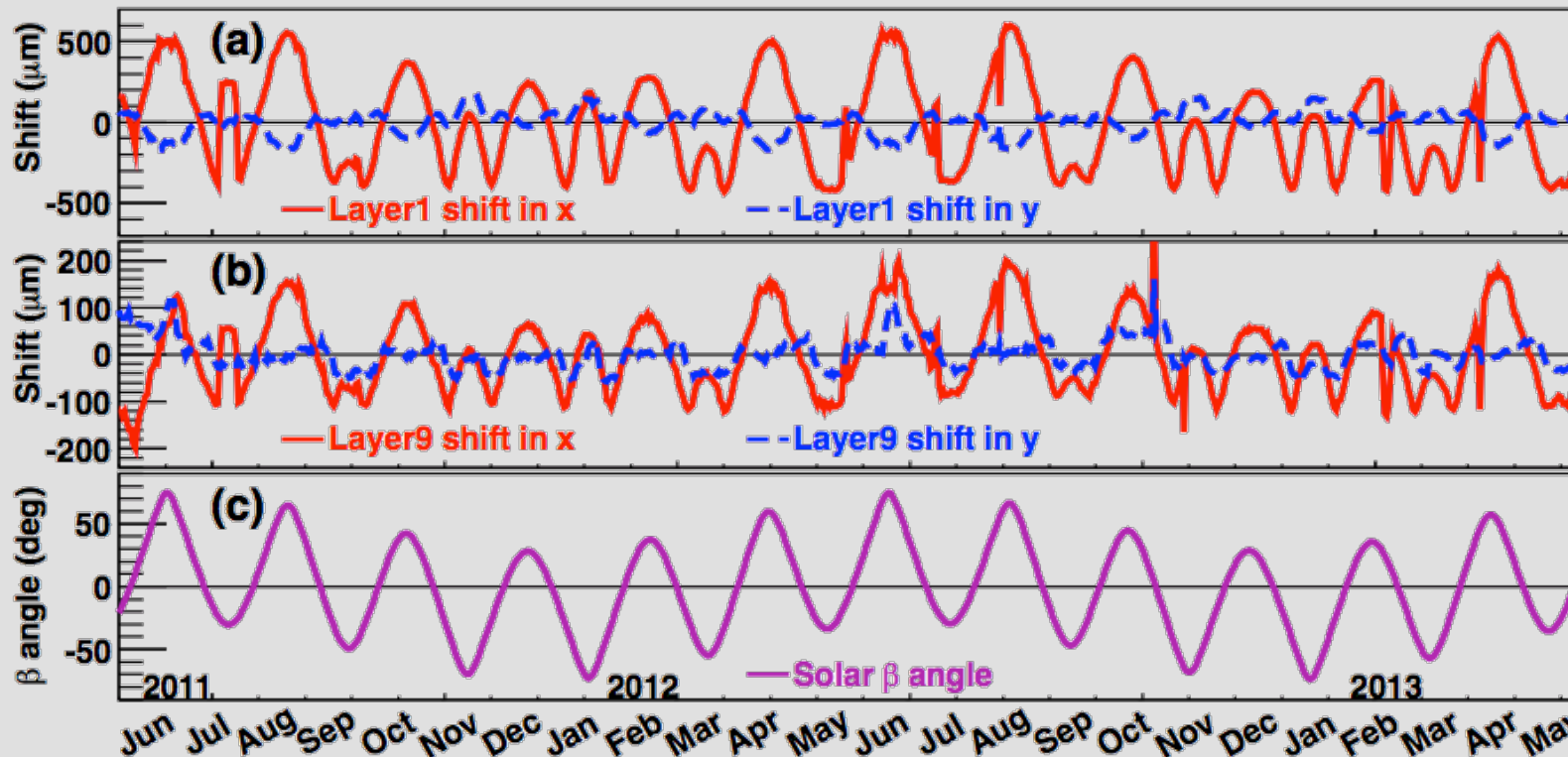


# Thermal Excursions : Effects



Relative Shifts of Inner Tracker Sensors between Test Beam and ISS Data.

→ **Static Alignment**

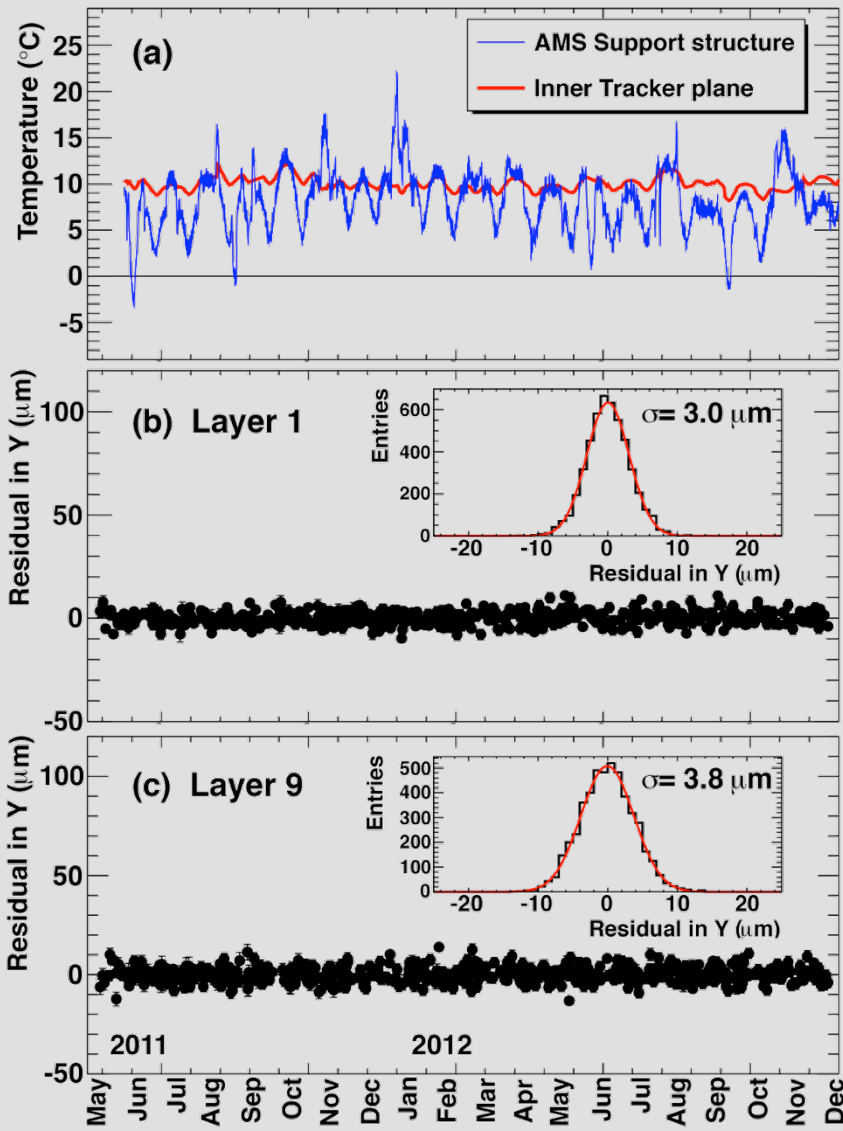


Movement of tracker layers with time before alignment.  
 → **Dynamic Alignment**

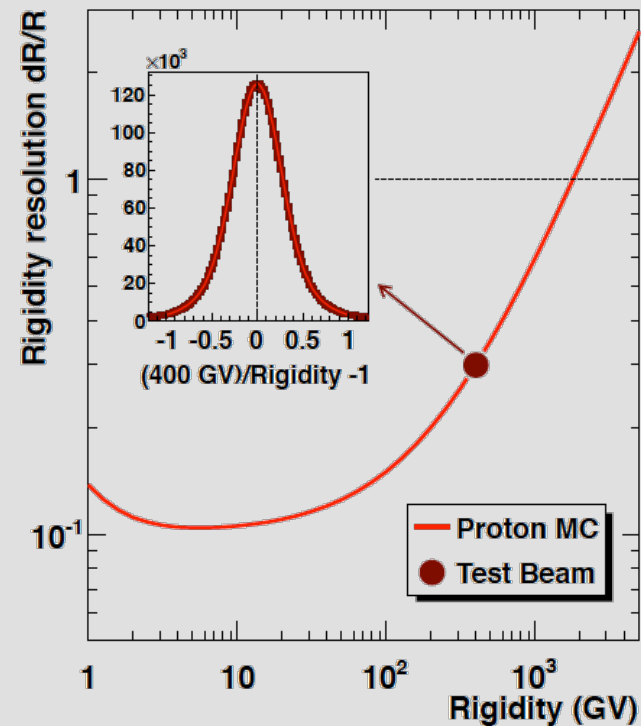
(Delgado, ICRC 2013))



# Alignment of the Silicon Tracker (Stability in Time)



- Static Alignment Inner Tracker
- Dynamic Alignment External Layers
- Alignment error :  $7 \mu\text{m}$ .
- Rigidity resolution at 10% at 10GV
- **MDR for protons is  $\sim 1.8 \text{ TV}$**

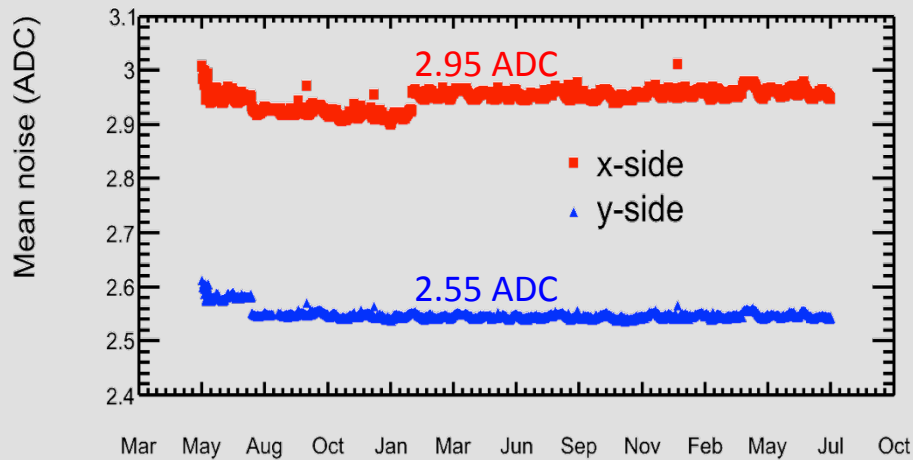
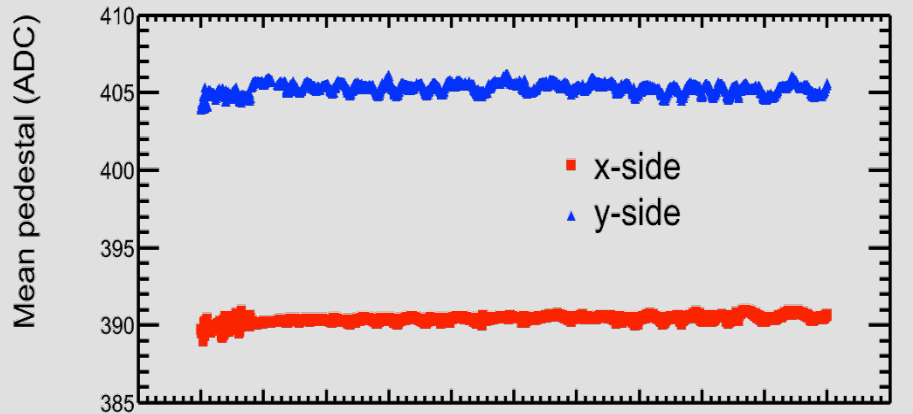


# Tracker Calibration Stability

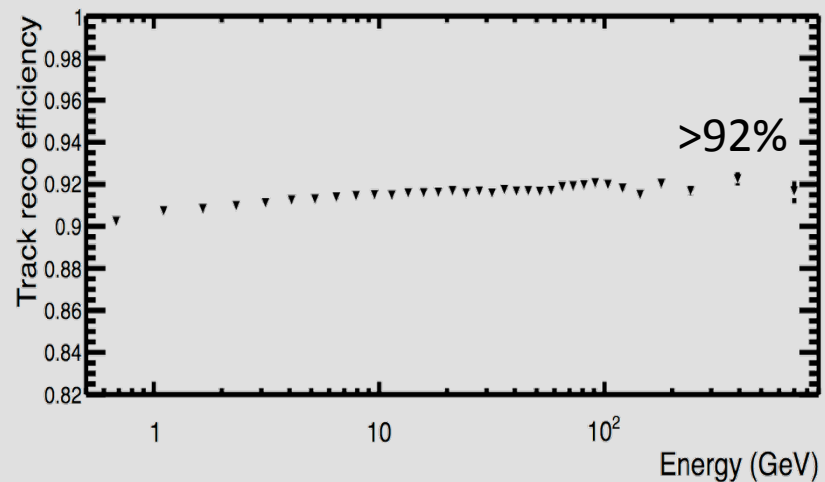
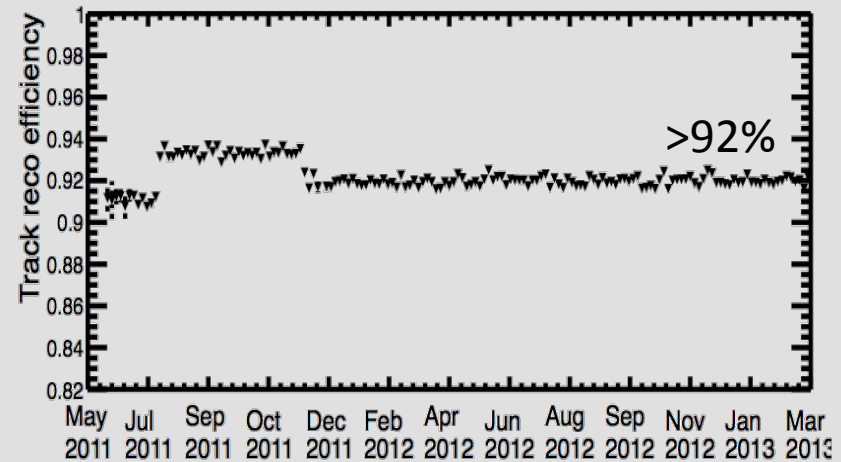


Calibration ( < 1 minute ) twice per orbit to account for temperature variations.

### Pedestal and Noise



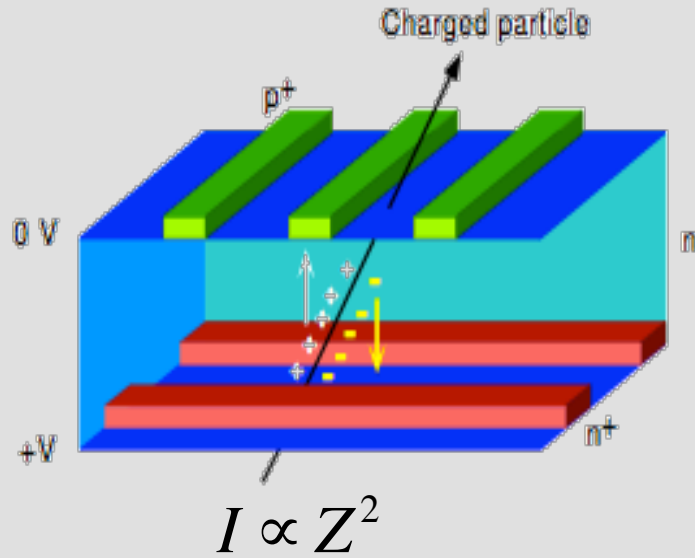
### Tracking Efficiency (using ToF)



(J. Bazaou, 2013 ICRC)

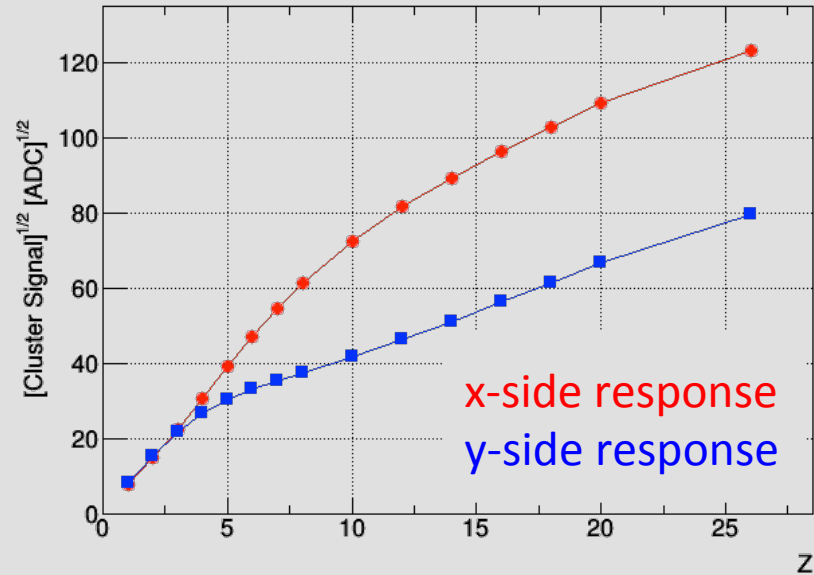


# Charge Measurement



$I \propto Z^2$   
( Bethe-Bloch )

### Tracker Response



Detector response degraded by variety of effects...



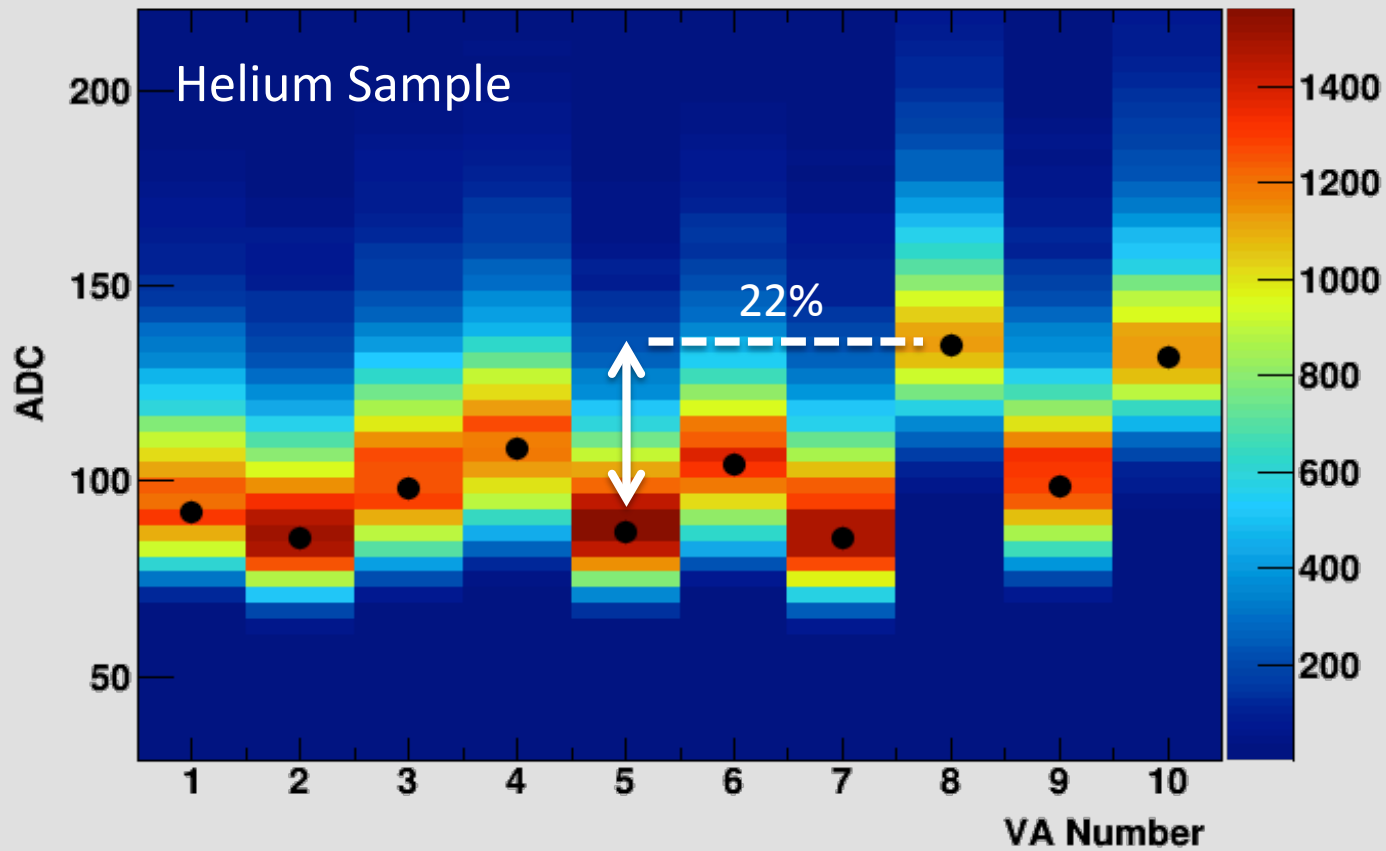
VA Equalization  
Collection Efficiency  
Energy Dependence

Construct a single energy independent tracker charge estimator

# VA Gain Differences



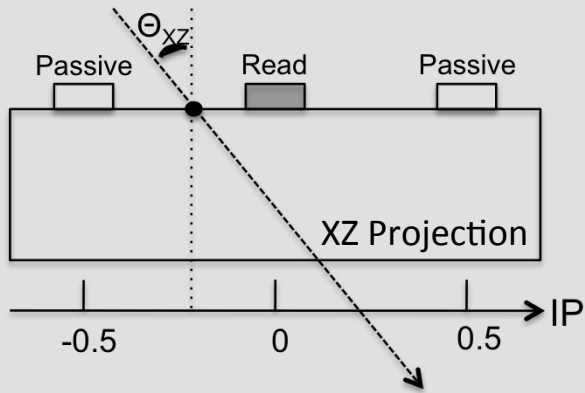
10 y-side VAs of single ladder



MPV of Landau convoluted with Gaussian used as main estimator of the gain of a given VA.

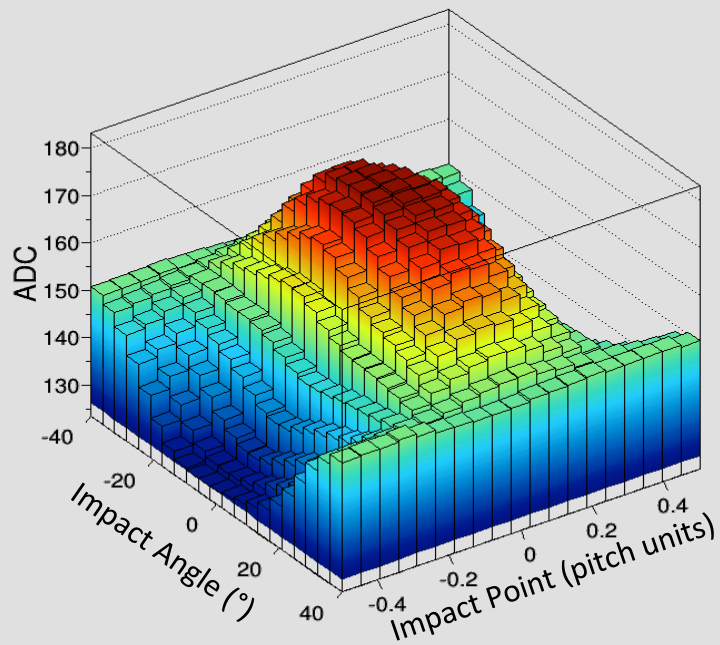


# Charge Measurement

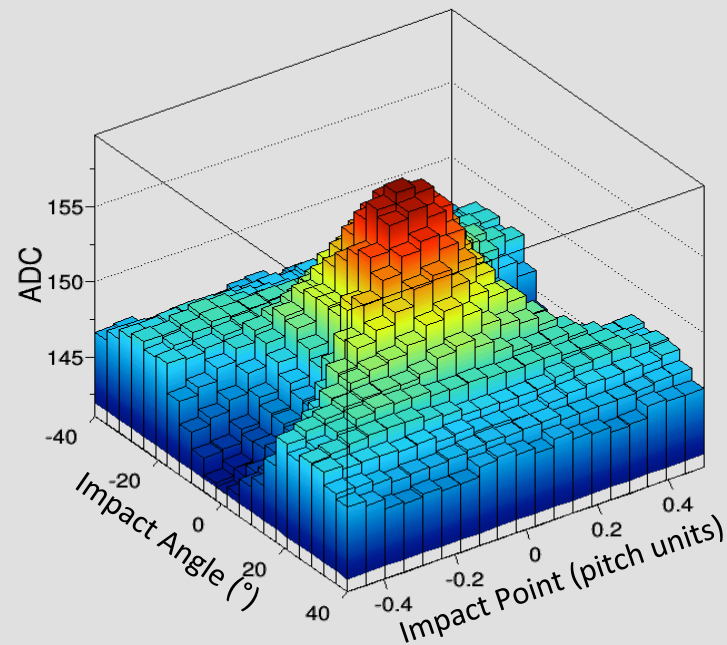


- $I_p = 0, \theta = 0$  : max collection
- $|I_p| = 0.5, \theta = 0$  : min collection
- Up to 30% difference in peak position
- Equalization procedure in each bin

Helium x-side



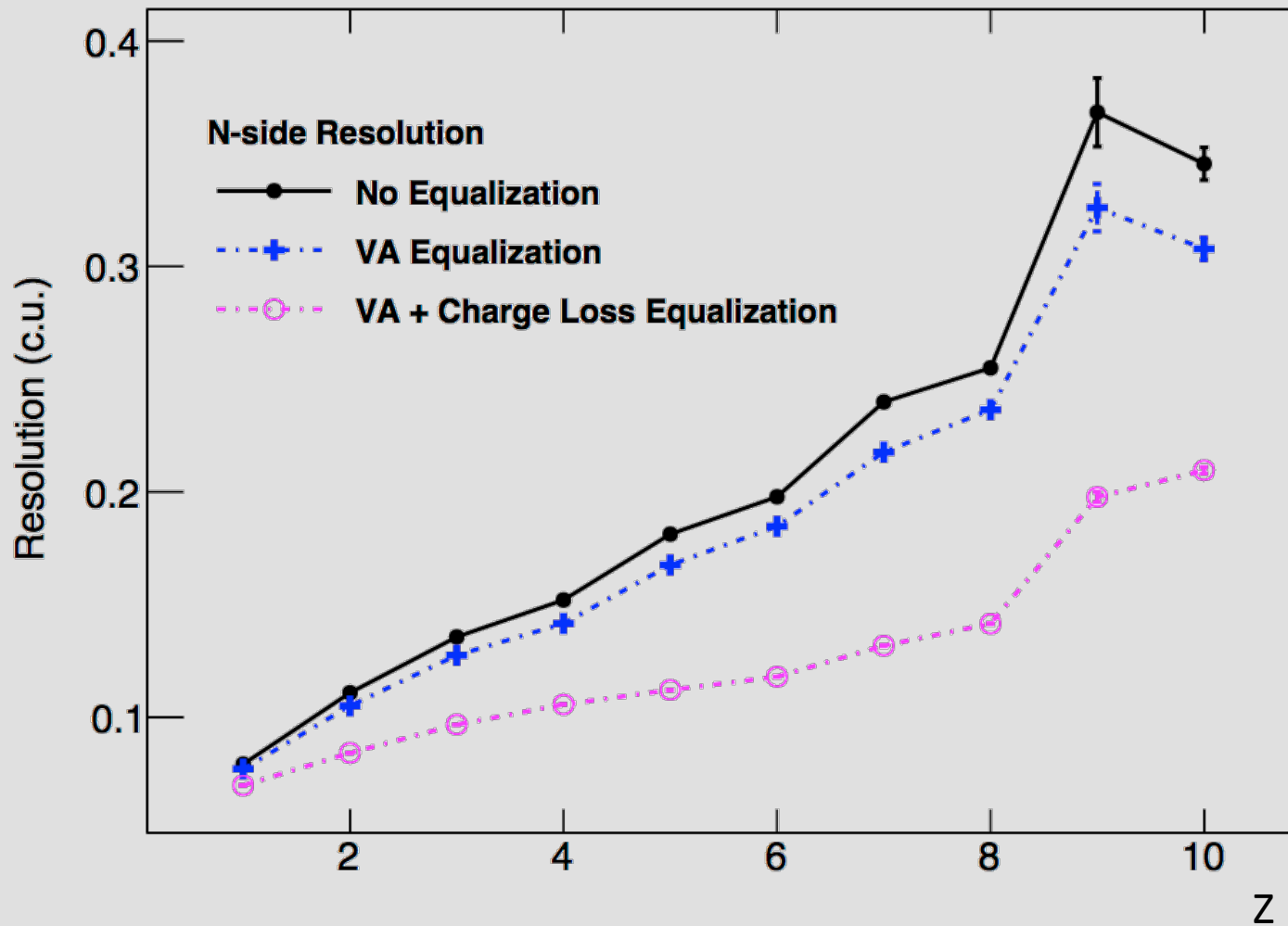
Helium y-side



# Resolution Improvement n-side



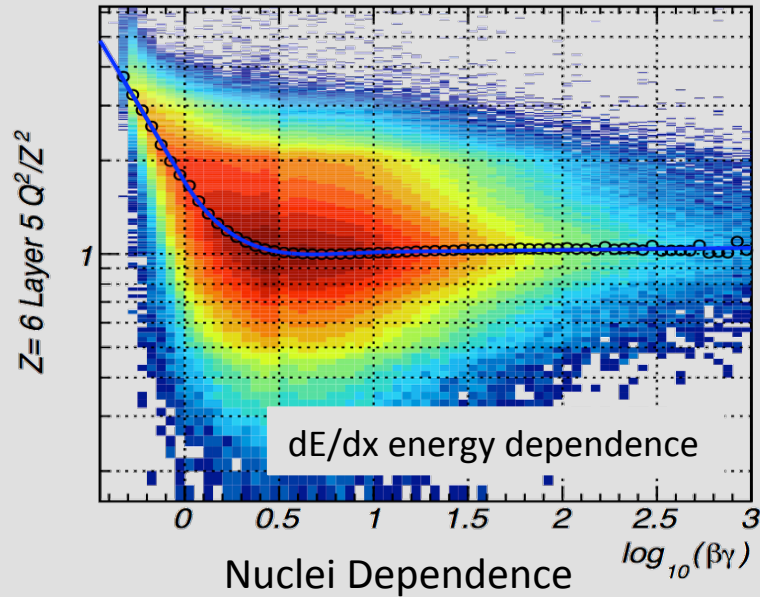
Using multi-Gaussian fit to extract resolution measurement.



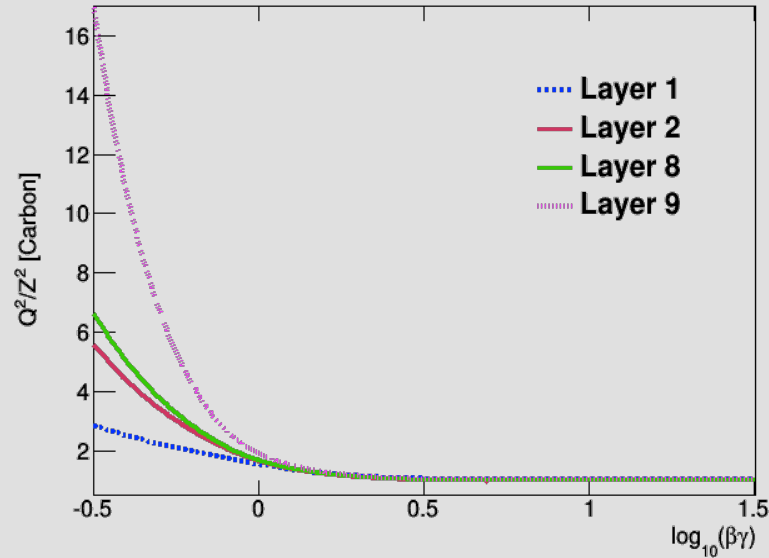
# Energy Loss $\beta$ Dependence



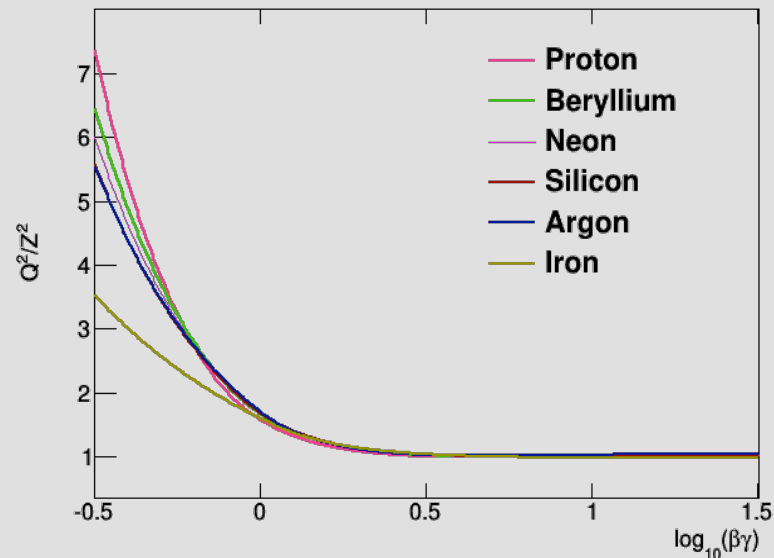
Parameterization



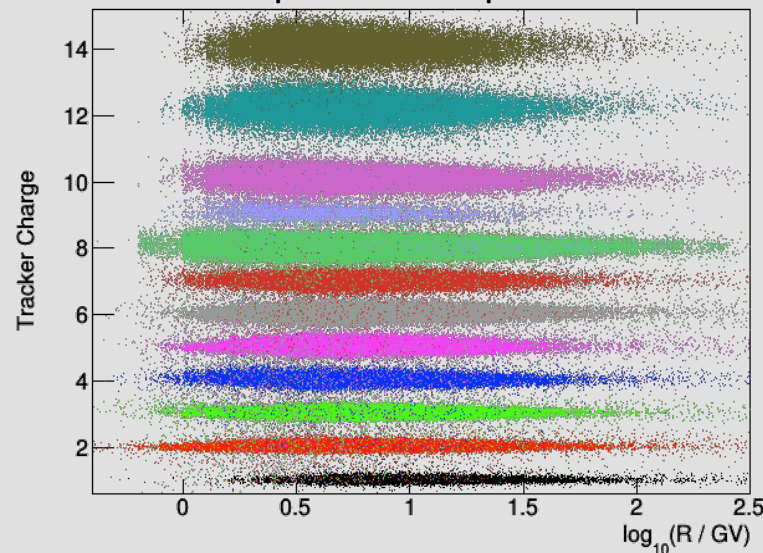
Layer Dependence



Nuclei Dependence



Equalized Response



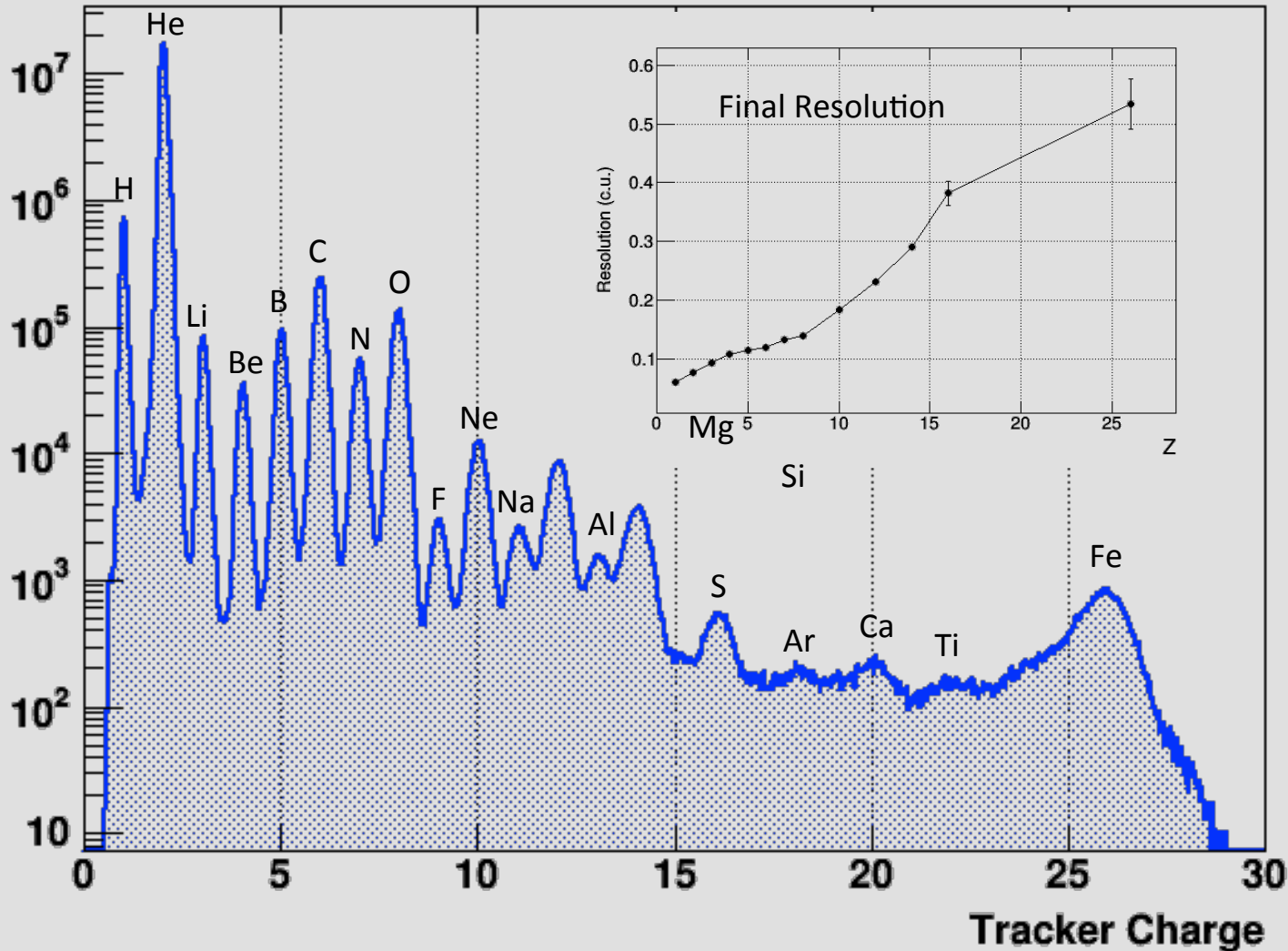


# Final Calibration Results



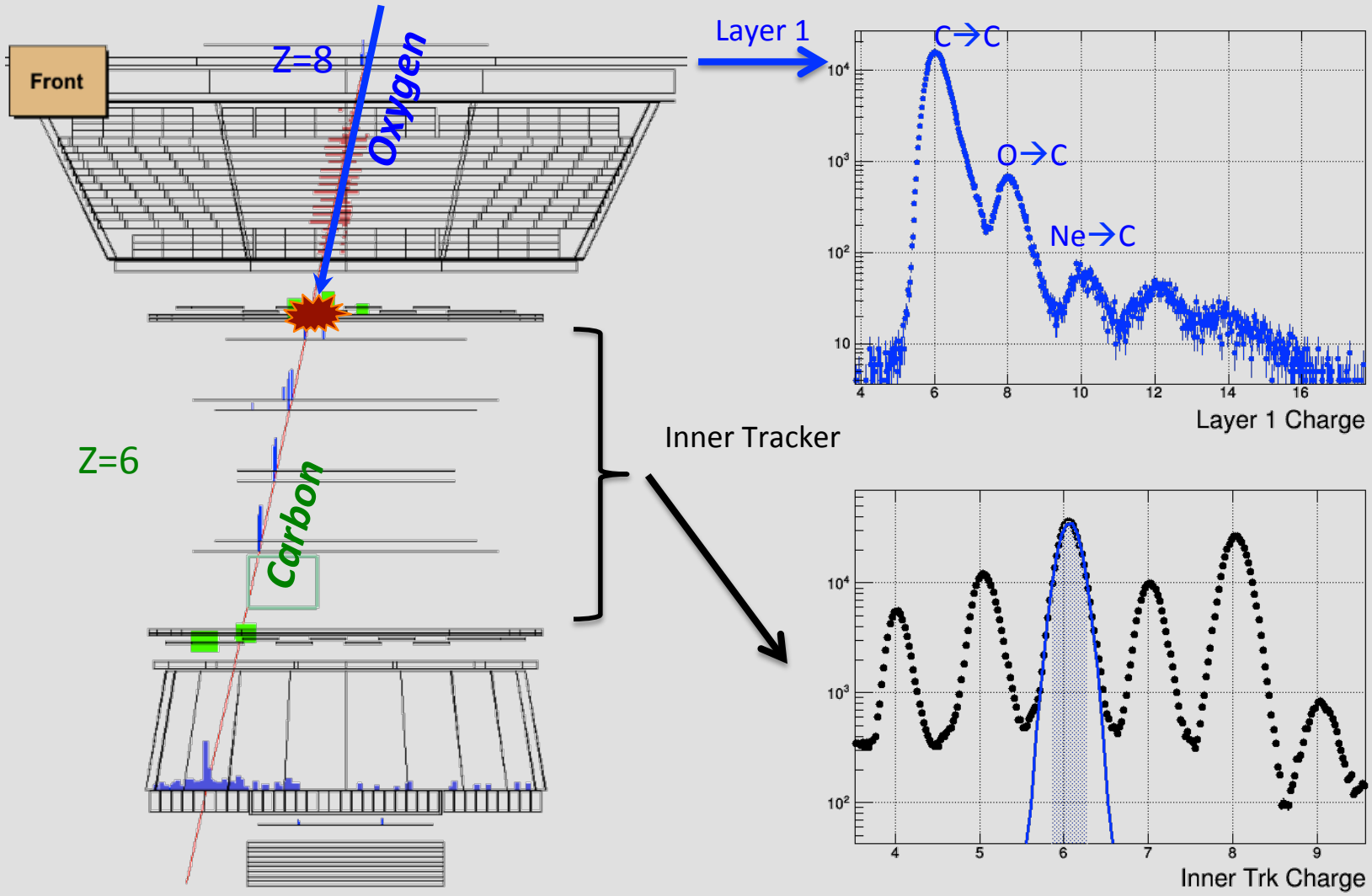
$$Q = \frac{Q_n w_n + Q_p w_p}{w_n + w_p} \quad w_i = \frac{1}{\sigma^2(n_{pts})}$$

Carbon misid. prob. at 99% selection efficiency is  $< 10^{-4}$



Contribution of H, He is pre-scaled in this plot.

# Redundant Charge Measurement



Crucial for nuclei flux measurements and secondary to primary nuclei ratios.

## Summary

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- Silicon Tracker operation in space most challenging due to the harsh thermal conditions.
- Precise control and detailed on-orbit calibration of the tracker allows best performances in terms of tracking efficiency and rigidity measurement.
- An accurate charge calibration of the tracker has been developed, resulting in a misidentification probability for carbon at the level of  $10^{-4}$ . Good identification capability up to Iron.
- The charge measured by individual tracker layers are essential tools to control fragmentation in the detector.

*Thank you for your attention...*

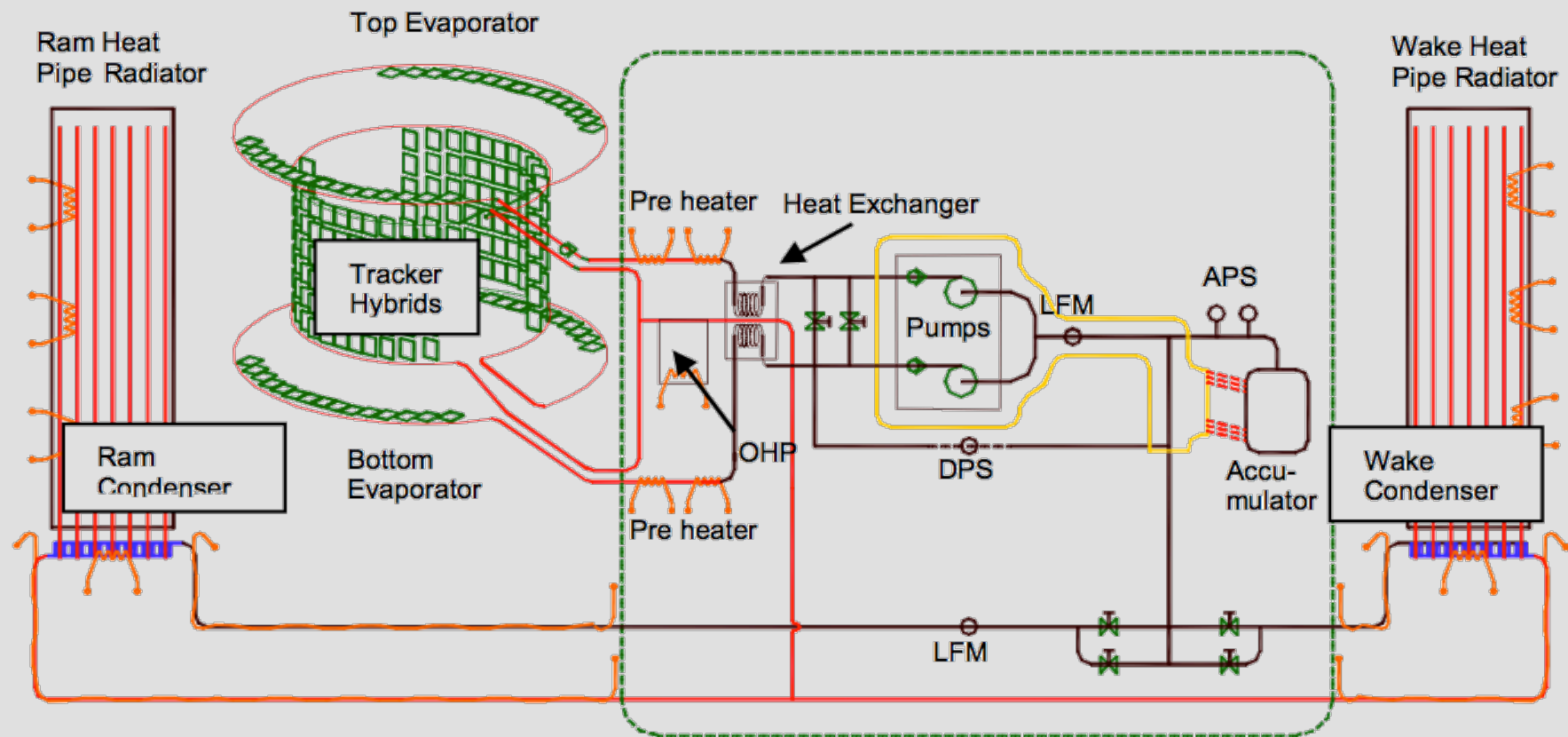


# *BackUp Slides*



# Tracker Thermal Control System (TTCS)

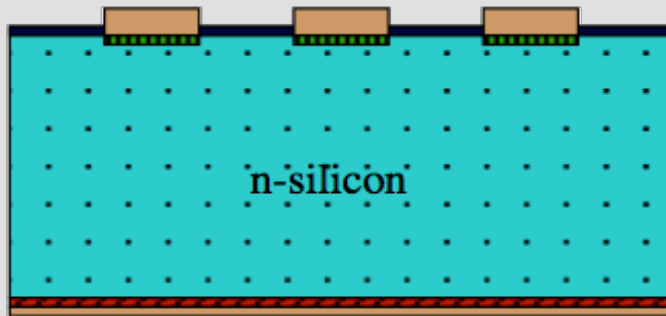
- TTCS is a 2 phases CO<sub>2</sub> pumped loop (first pumped CO<sub>2</sub> system in space).
- TTCS can remove 125 W from layer 2 to layer 9.
- Layer 1, facing deep space, only needs a heater.



# Silicon Sensor Design (P. Azzarello, 2004)

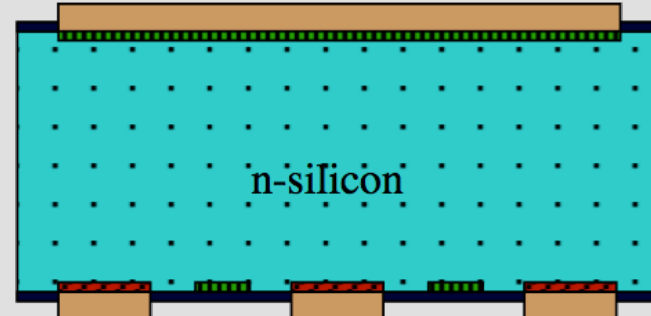


p-side slice



- Aluminium
- p<sup>+</sup>-silicon
- SiO<sub>2</sub> layer
- n<sup>+</sup>-silicon

n-side slice



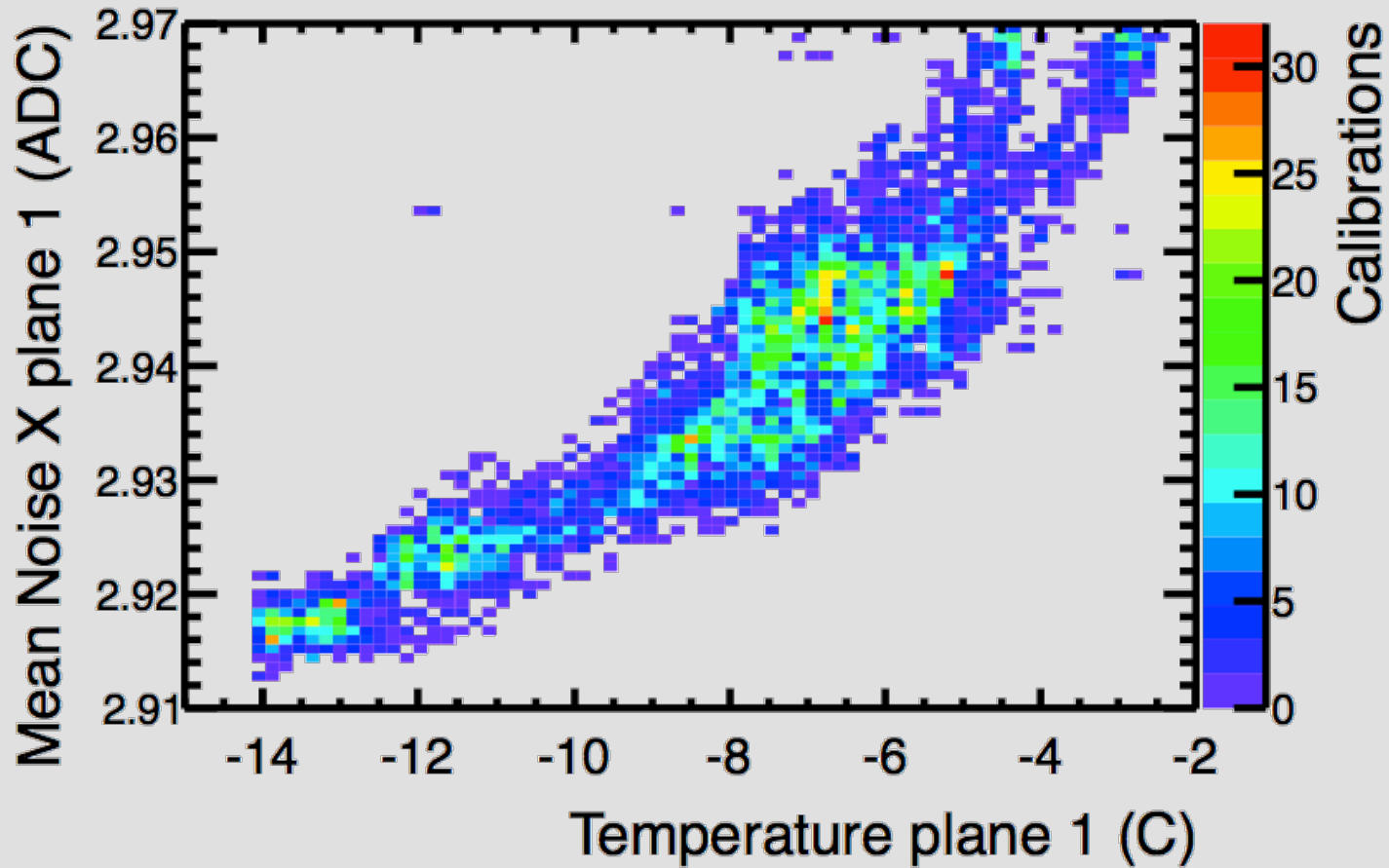
- Aluminium
- p<sup>+</sup>-silicon
- SiO<sub>2</sub> layer
- n<sup>+</sup>-silicon

Max. depletion voltage	50 V
Max. total leakage current	2 μA
p-side hot strip definition	$I_{strip} > 2 \text{ nA}$
n-side hot strip definition	$I_{strip} > 20 \text{ nA}$
Max. number of p-side hot strips	6
Max. number of n-side hot strips	4

Table 3.1: Selection criteria applied to the AMS-02 silicon microstrip detectors [49].



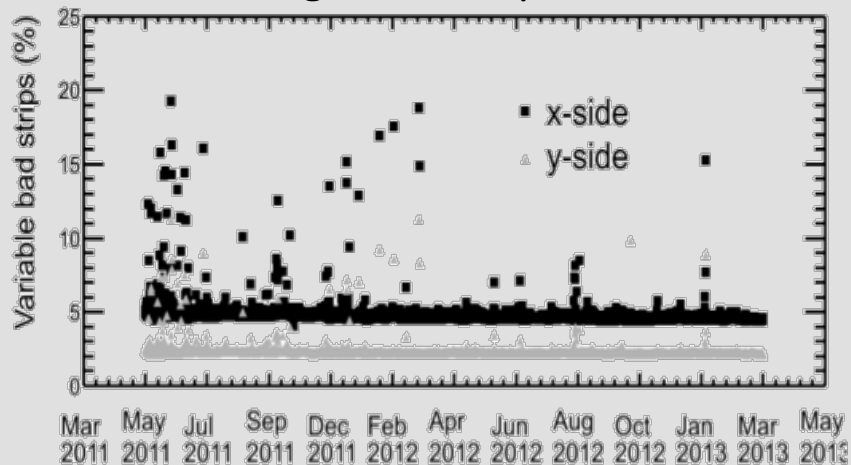
# Noise versus Temperature



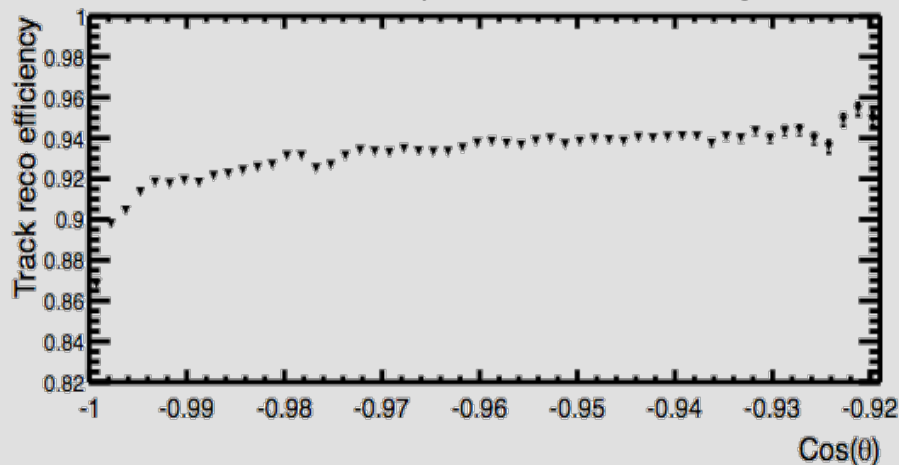
# Tracker Performance



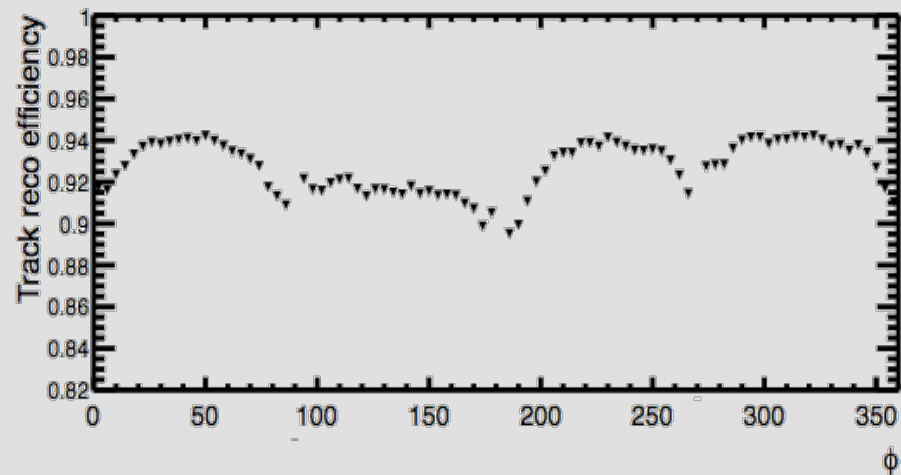
### Percentage Bad Strips vs Time



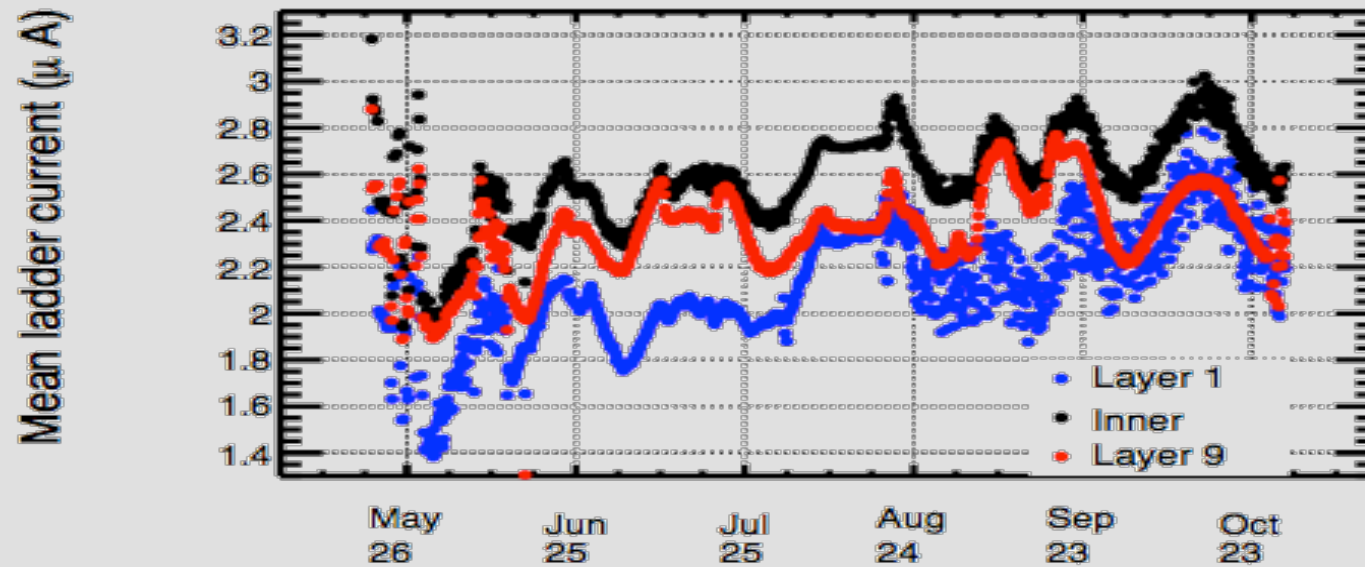
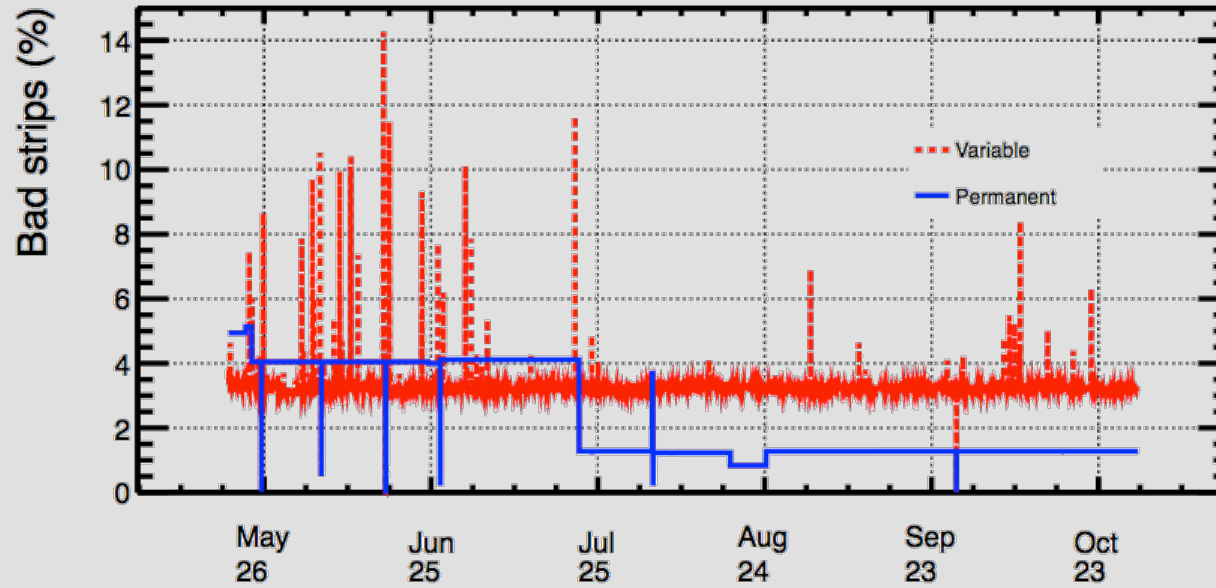
### Track Efficiency vs Incident Angle



### Track Efficiency vs Azimuthal



# Noise versus Time

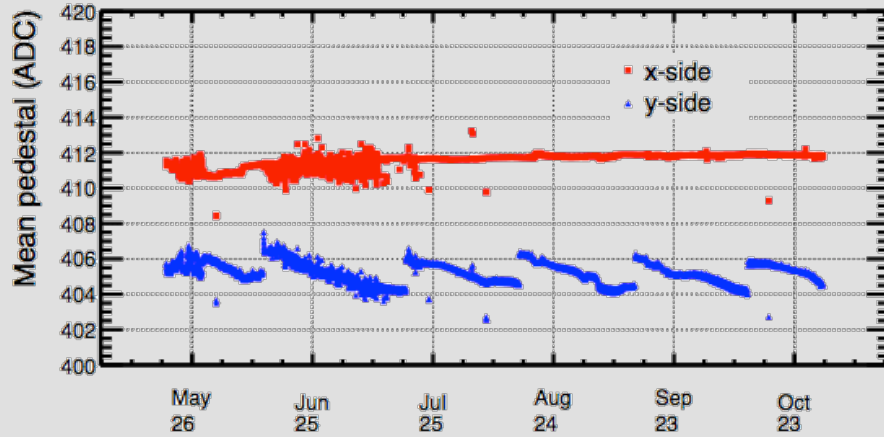




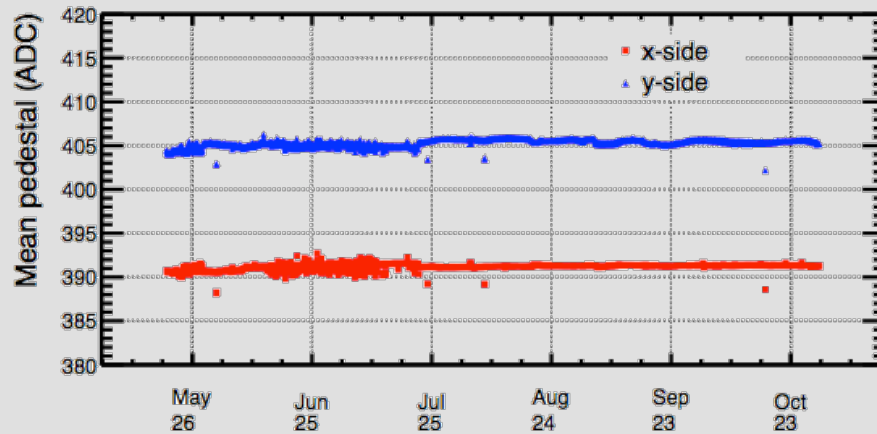
# Pedestal Behavior



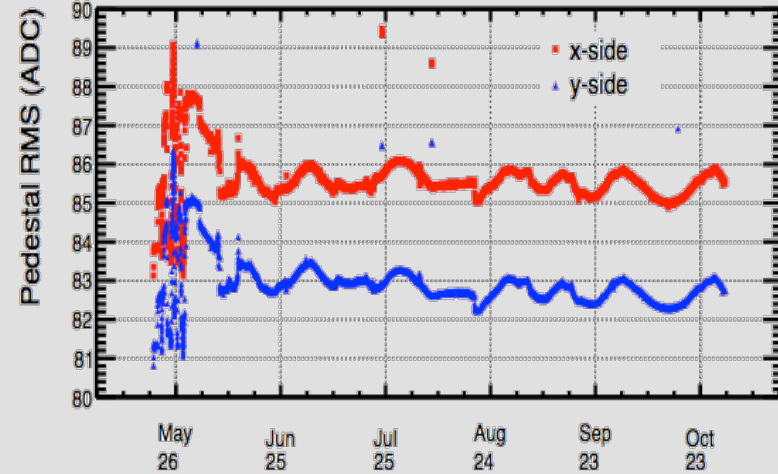
## Mean Pedestal



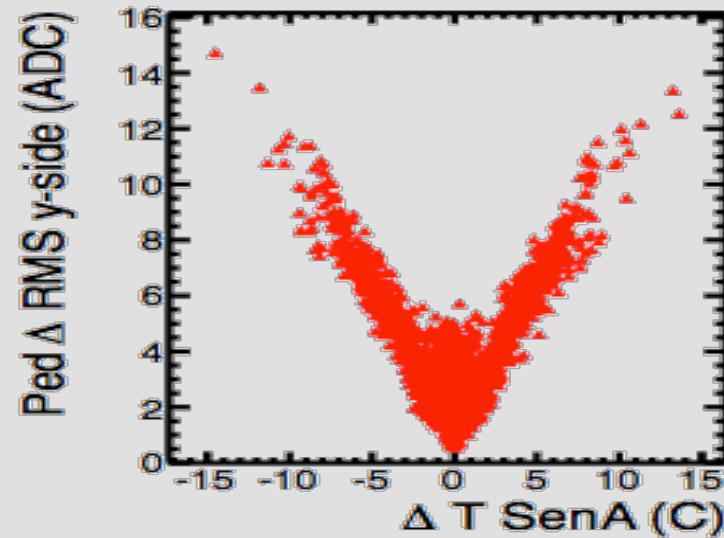
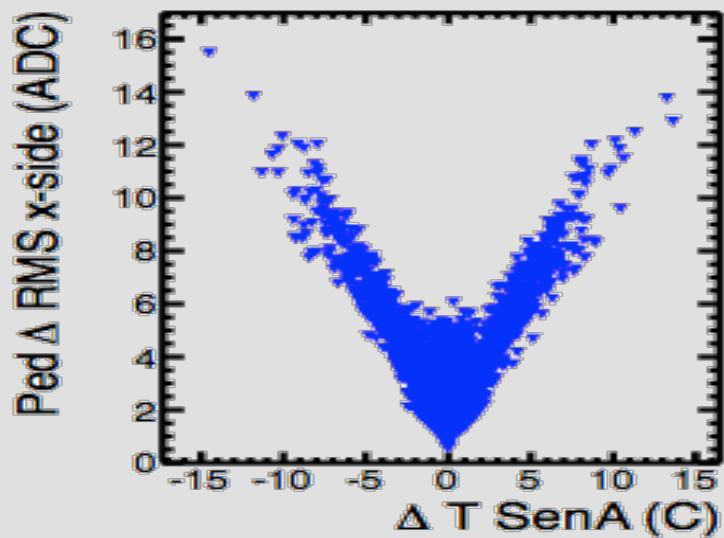
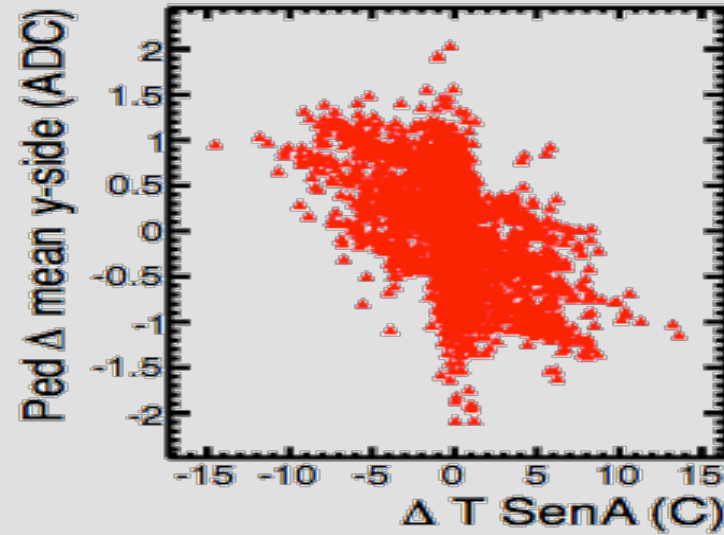
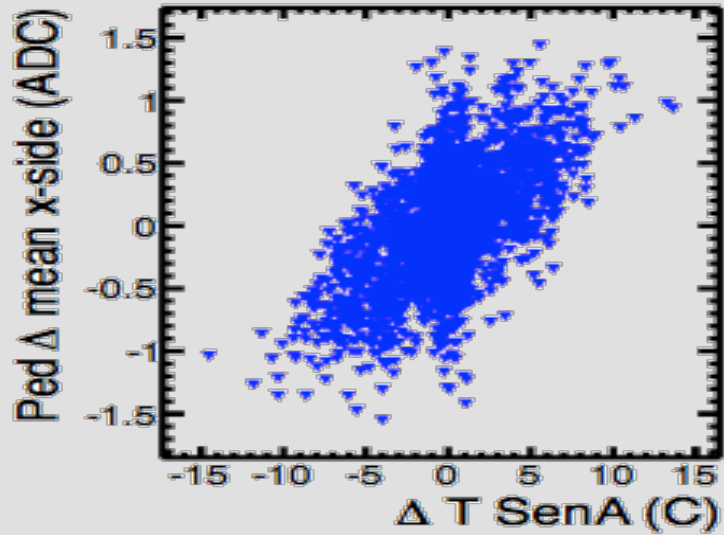
↓ removing permanent bad strips and pathological ladder



## Pedestal RMS



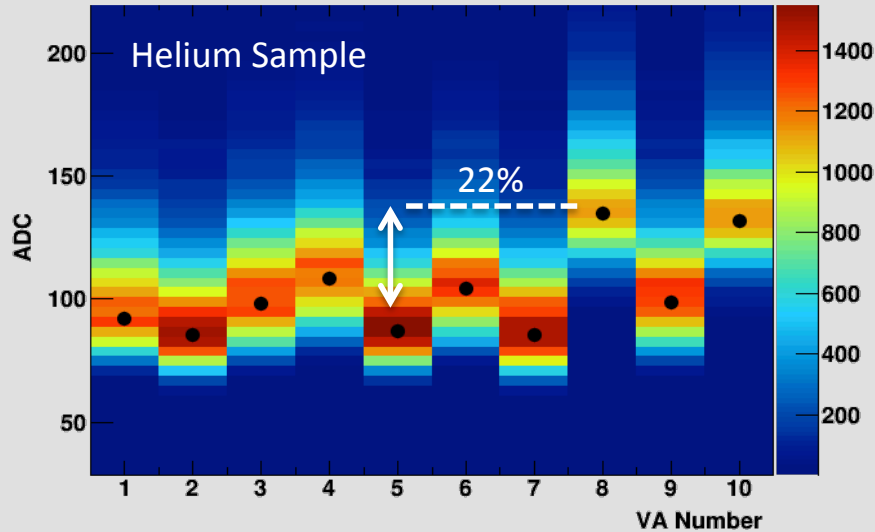
# Pedestal Dependence on Temperature



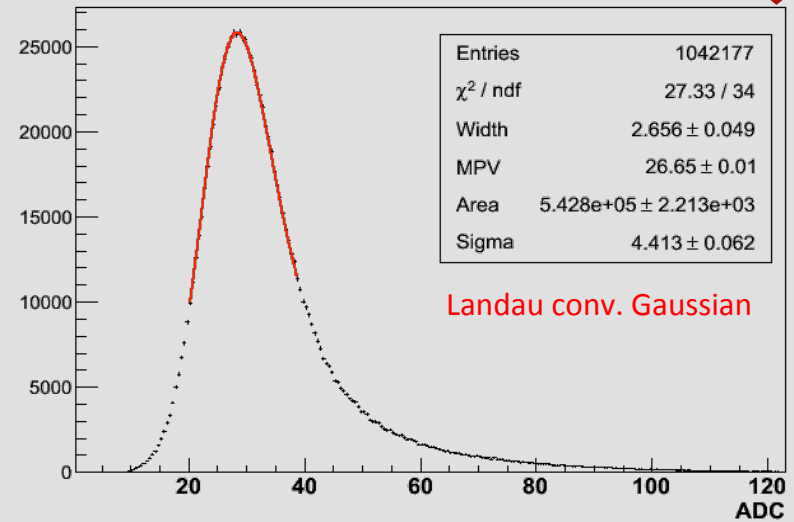
# VA Equalization



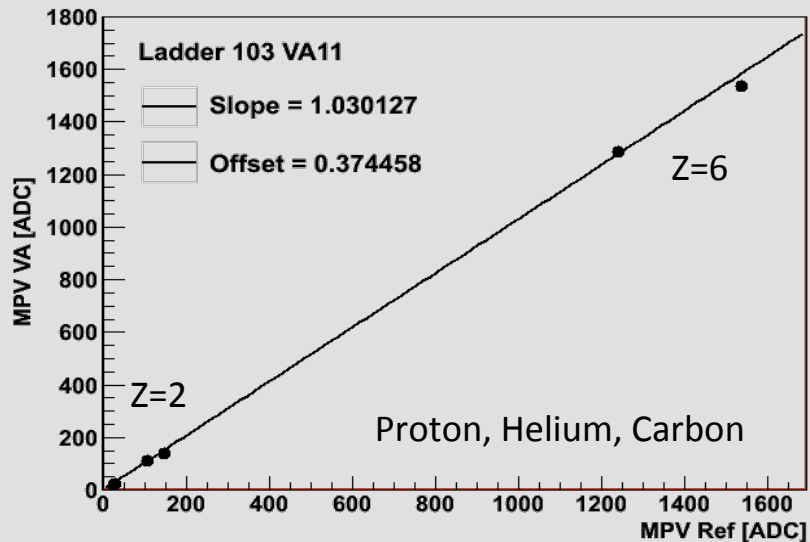
10 p-side VAs of single ladder



Single VA ADC distribution



MPV (VA) versus MPV (Ref.)

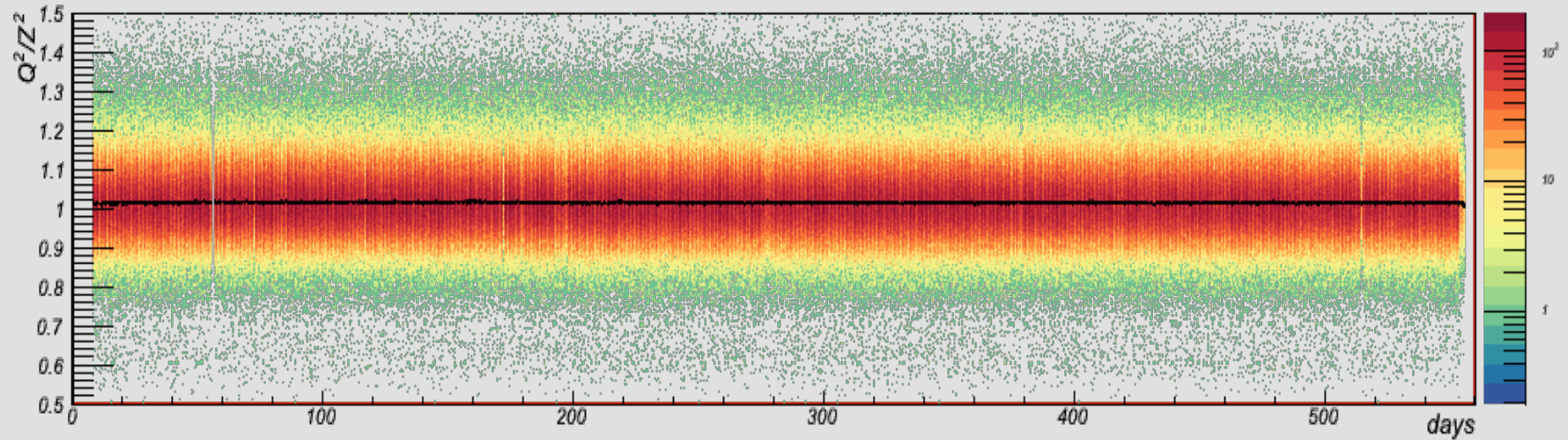


$$ADC_{\text{Corr}} = \frac{1}{\text{slope}} (ADC_{\text{Meas}} - \text{offset})$$

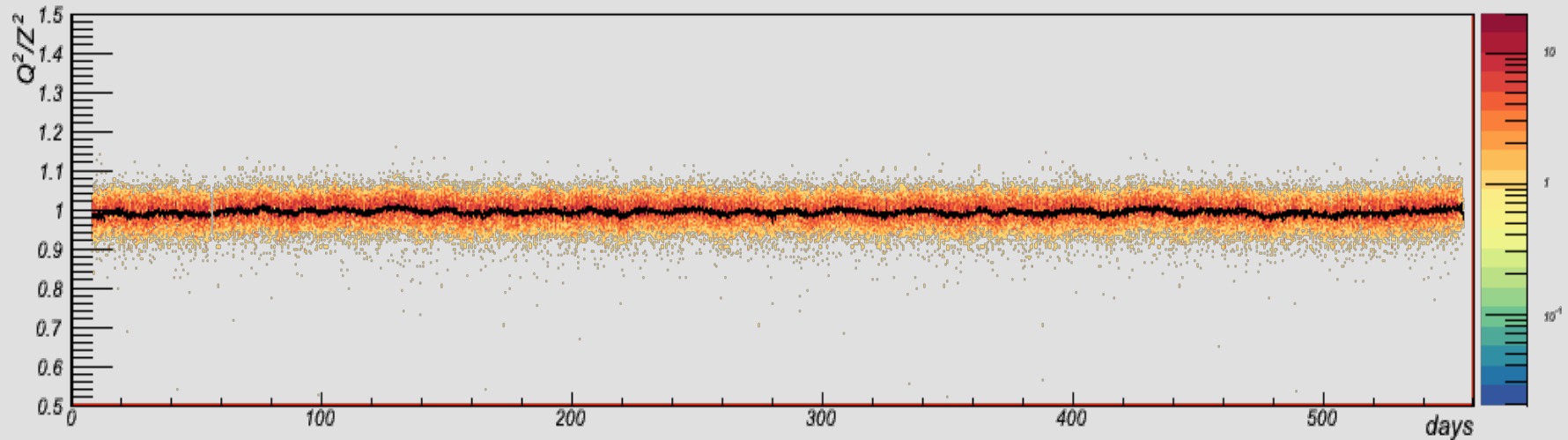
# Time Stability of the Tracker Measurement



## X-Side Z=1



## Y-Side Z=26





# Final Calibration Results

